

Docket No.: 50090-332

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of	:	Customer Number: 20277
Hisaya MORI, et al.	:	Confirmation Number: 4507
Application No.: 09/927,368	:	Group Art Unit: 2829
Filed: August 13, 2001	:	Examiner: J. M. Hollington
For: APPARATUS AND METHOD FOR TESTING SEMICONDUCTOR INTEGRATED CIRCUIT		

PETITION FOR EXTENSION OF TIME

Mail Stop AF
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

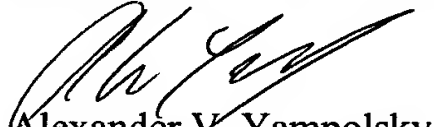
It is respectfully requested that the time for response to the Office Action dated August 12, 2004, now due to expire November 12, 2004, be extended for one month(s) and set to expire on December 12, 2004.

Please charge the extension fee of \$120.00 to Deposit Account No. 500417. Please charge any additional fees or credit any overpayment to Deposit Account No. 500417.

Respectfully submitted,

12/14/2004 CNGUYEN 00000047 500417 09927368
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Date: December 13, 2004

**Please recognize our Customer No. 20277
as our correspondence address.**